



Vision Measuring Systems

Vision Measuring Machine with Micro-Form Scanning Probe MiSCAN Vision System



A thoroughbred microscopic-form measurement system, developed from coordinate measuring machine and vision measurement system technology





Newly developed **MPP-NANO** probe on which styli as small as 125 µm diameter can be mounted achieves autonomous scanning of fine detail. Using the observation camera, the approach to the workpiece can be easily performed while also checking for dirt and scratches on the workpiece. The highly proven **SP25M** scanning probe is also supported so the system can also be used for large workpieces as well as small.

Vision measurement functions provide high level performance



Scan to view video

Uses the same image head as the Quick Vision series, the best-selling vision measuring system. Also equipped with the same optical system as the Quick Vision, multiple lighting functions and excellent evaluation software to provide high performance.

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Measuring machine well suited to micro-form measurement

Ideal hybrid measuring machine with vision head and scanning probe (MPP-NANO, SP25M). The image head enables precise positioning and targeting measurement even in shrouded locations where visual checking is difficult.





Precise positioning by monitoring the image

For the **MPP-NANO** stylus, an observation unit is available as an option. Even when using the extra small 0.125-mm-diameter stylus, checking on the monitor enables a safe approach to the measuring point.



A magnetic kinematic joint connection enables easy stylus replacement. Stylus replacement tools, which are in the **MPP-NANO** stylus tool kit, are supplied as standard.









MPP-NANO stylus



In recent years, the need for fine-detail processing technology has been increasing rapidly, including the sensing technology essential for vehicle motorization and autonomous driving. Simultaneously, enabling highaccuracy, high-throughput measurement of microscopic form is required. Mitutoyo responded quickly to these needs, and started selling the Micro Form Measuring System UMAP Vision System some time ago. According to the current need for improving productivity, we have developed the MiSCAN Vision System, a measuring system capable of measuring micro form with the MPP-NANO, a small diameter scanning probe.

Examples of micro-form measurement achieved with the MiSCAN Vision System and MPP-NANO

Microscopic gear teeth

Conventionally, highly efficient scanning of microscopic gear teeth whose module is one or lower has been difficult. However, using the MISCAN Vision System together with the MPP-NANO enables this scanning. Simply enter each nominal using GEARPAK, which is the gear teeth evaluation software, to easily evaluate the tooth profile error and tooth trace error.



Module 0.8 master gear measurement



Measurement using the MPP-NANO 0.125-mm-diameter stylus

Lenses and optical tubes



GEARPAK-Cylindrical analysis



The MiSCAN Vision System and MPP-NANO enables high-accuracy, highly efficient measurement of miniaturizing and evolving optical tubes. The MPP-NANO can measure the contour of high degree aspheric lenses used in the vehicle-mounted camera with high accuracy.



Aspheric-form **MPP-NANO** measurement



SCANPAK form analysis example

Precision molds

The MiSCAN Vision System and MPP-NANO enable scanning measurement of microscopic feature detail, such as precision punches and dies, using extra-small-diameter styli, which are available with diameters as small as 0.125 mm.



MPP-NANO mold scanning



camera unit



Image seen using the stylus observation SCANPAK form-analysis example



Precision mechanical parts

The MiSCAN Vision System and MPP-NANO enable highly efficient, high-accuracy measurement of miniature mechanical parts that improve precision in industrial machinery.



Precision mechanical parts (linear guide)

Image seen using the stylus observation camera unit

Micro-hole measurement

Conventionally, only destructive measurement was possible for the inner diameter of nozzles and draw dies. However, the MiSCAN Vision System and MPP-NANO now enable performing scanning measurement using the stylus on holes with a maximum aspect ratio of 17:1.





Maximum aspect ratio: 17:1 (for R500-125-85)

MPP-NANO micro-hole measurement

Fine detail contour analysis

Optional CAT1000S (optional) software enables nominal scanning measurement and form evaluation of micro V-grooves and rectangular grooves.





Creating nominal sections from CAD data (CAT1000S)







FORMTRACEPAK-AP form analysis example

1 3 3 A P . P . P . 1 1 3 3

FORMTRACEPAK-AP analysis results

SCANPAK design value verification

MiSCAN Vision System



Specifications

Model	•		Hyper MVS 302	Hyper MVS 404	MVS Apex 404			
Model No.			MVS-H302P1L-D	MVS-H302P1L-D MVS-H404P1L-D				
Image			300x200x200 mm	400x400;	J0x250 mm			
weasuring range	MPP-NANO/SP25M		175x200x200 mm	175x200x200 mm 275x400x250 mm				
Minimum reading/Scale unit			0.02 µm/Lin	0.1 µm/Linear encoder				
Image sensor			B&W CCD camera					
Observation unit			Power turret (1X-2X-6X)					
Illumination unit			Co-axial light, transmitted light, PRL (programmable ring light)					
Contact type probe			MPP-NANO/SP25M	Only S	P25M			
	Image*1	E1x, E1y	0.8+2L/1000		1.5+3L/1000			
Measurement		E1z	1.5+21	1.5+4L/1000				
accuracy		E2XY	1.4+3L/1000		2.0+4L/1000			
[µm]	MPP-NANO	Еомре	1.9+4 L/1000	-				
	SP25M	Еомре	1.9+4L/1000		2.5+6L/1000			
Copping accuracy	MPP-NANO		0.6	0.6 —				
	CDOEM	PForm.Sph.Scan:PP:Tact,MPE	2.5		2.7			
[hiii]	JFZJIVI	auSph.Scan:PP:Tact,MPL	50 s					
Probing accuracy	MPP-NANO		0.6	-	_			
[µm]	SP25M	PForm.Sph.1×25:SS:Tact,MPE	1.9		2.2			
Repetitive accuracy [µm]	itive accuracy [µm] MPP-NANO		0.05		_			
Accuracy guaranteed	Ambient temperature		18 - 23 °C					
temperature	Temperature variation		0.5 °C/1 H and 1 °C/24 H					
Size of stage glass			399x271 mm	493x55	x551 mm			
Max. mass of workpiece*2			15 kg	30 kg	40 kg			
Dimensions			859x951x1609 mm	1407x1027	7x1778 mm			
Mass (Including machine stand)			360 kg	579 kg				

*1 Image accuracy using a QV-HR 2.5X objective and 2X tube lens.

*2 Except at limits of stage displacement or concentrated loading.

Note1: Accuracy-guaranteed machines conforming to ISO10360-7:2011 are also supported.

Note2: CNC Vision Measuring Systems in this brochure incorporate a main startup system (relocation detection system) that disables operation when an unexpected vibration occurs or the machine is relocated. Be sure to contact your nearest Mitutoyo Sales Office prior to relocating your machine after initial installation.





The world's most compact and accurate scanning probe

- features.
- (ø500L8.5).
- ≤ 0.05 µm (**MVS-H302**).
- the workpiece.



0.6

0.08





- measurement (optional).



NISHA

SP25M







MPP-NANO For MVS-H302

• Styli as small as a 0.125 mm-diameter are available for scanning measurement of fine-detailed

• Deep grooves and deep holes can be measured at the maximum aspect ratio of 17:1

• High accuracy form measurement is enabled by achieving high repeatability:

• The measuring force is as low as approximately 1 mN. Therefore, it will not scratch or deform

• The stylus can easily be replaced thanks to the magnetic joint connection. • The stylus observation unit (optional) enables easy positioning of the stylus tip.

Specifications								
MPP-NANO stylus, ø125L2	MPP-NANO stylus, ø300L4	MPP-NANO stylus, ø500L4.5	MPP-NANO stylus, ø500L8.5					
R125-85-20	R300-85-40	R500-85-45	R500-125-85					
125 µm	300 µm	500 µm	500 µm					
2 mm	4 mm	4.5 mm	8.5 mm					
0.08 mm	0.08 mm	0.2 mm	0.3 mm					
16	13.3	9	17					
Ruby	Ruby	Ruby	Ruby					



Compact, high accuracy scanning probe

• The highly proven SP25 scanning probe used with 3D measuring machines can be mounted. • Stylus changer FCR25 (optional) handles multiple styli, including one in the horizontal position, and enables automatic stylus changes.

• Captures the target point in high-accuracy point measurement and centripetal aligning point



Non-contact measurement (vision measurement)

The **MiSCAN Vision System** is equipped with an optical observation system and an illumination unit of the **QUICK VISION** measuring system. It can perform as a high-level vision measuring system.

VISIONPAK-PRO (required option)

High-level vision measurement functions are equipped, including a one-click tool that enables easy edge detection; a dual-area contrast tool that automatically recognizes optimal illumination; and filters (morphology filter) that enable highly accurate edge detection.



High-accuracy vision measurement

High-accuracy edge detection is performed using the image obtained by the image sensor.

Programmable power turret

The observation unit uses a high-resolution programmable power turret with high magnification repeatability.





Programmable ring illuminator

A high-function programmable ring illuminator that has the ability to control the irradiation angle and direction is equipped as standard.













SCANPAK (required option)

Using contour data obtained by the **MiSCAN Vision System**, nominal verification, best-fit contour construction and more are available in addition to element calculation.



FORMTRACEPAK-AP (optional)

Using data obtained by the **MiSCAN Vision System** enables highly sophisticated analysis including nominal verification, over-pin diameter measurement and arbitrary depth measurement.



Contact measurement/ Scanning measurement

The **MiSCAN Vision System** uses the main unit controller and software that have long been used in 3D measurement and provides high-level coordinate measurement technology.

The auto

Image auto focus

The auto focus enables non-contact high-accuracy height measurement. Pattern focus enabling focusing on transparent and mirror objects is also equipped.





MCOSMOS (required option)

MCOSMOS has long been used in 3D measurement; in addition to size measurement, it offers very powerful geometric tolerancing functions such as linear contour and plane contour evaluations.



MCOSMOS flatness drawing

CAT1000S (optional)

Using 3D CAD data, section extraction in the nominal scanning or linear and plane contour evaluations are available.



Main options

Objective lens



Objective lens		QV-SL0.5X*1*2	QV-HR1X	QV-SL1X	QV-HR2.5X	QV-SL2.5X	QV-HR5X	QV-5X	QV-HR10X*2	QV-10X*2	QV-25X*2
Working dis	stance	30.5 mm	40.6 mm	52.5 mm	40.6 mm	60 mm	20.0 mm	33.5 mm	20 mm	30.5 mm	13 mm
PRO model	Turret 1X	12.54×9.4	6.27×4.7		2.49×1.86		1.25×0.94		0.62×0.47		0.25×0.18
imaging area	Turret 2X	6.27×4.7	3.13	×2.3	1.24>	1.24×0.93 0.62		×0.47	7 0.31	(0.23 0.12	0.12×0.09
[(H) mm × (V) mm]	Turret 6X	2.09×1.56	1.04>	<0.78	0.41>	<0.31	0.20>	×0.15	0.10>	(0.07	0.04×0.03

*1 Cannot be used with MPP-NANO because the offset calibration with the probe is not supported.

*2 When using a QV-SL0.5X, QV-HR10X, QV-10X or QV-25X objective, partial functional limitations such as insufficient light intensity may occur depending on the target workpiece.



• Stylus observation camera unit for **MPP-NANO** • Master ball (ø4) Calibration gauge



• For FCR25 SP25M • Master ball (ø16) Calibration gauge

External dimensions and measuring ranges







550 339 755 1027 2700 1407

145 47

86

MVS-X404/MVS-X302



Traceability

Traceability to the national standard of length

- Mitutoyo owns standard scales that are traceable to the national standard of length and these are used to calibrate the reference gages used for calibration of measuring instruments, thus establishing and maintaining traceability for each instrument.
- Our calibration organizations are accredited by IAJapan, a signatory to the Mutual Recognition Arrangement (MRA) of the International Laboratory Accreditation Cooperation (ILAC), and approved of as having the measurement skills equivalent to those of overseas organizations.

Reliable support system

The world's top-level global network

Following the establishment of MTI Corporation (U.S.) in 1963, Mitutoyo has been expanding its market throughout the world. Currently, the company has R&D, manufacturing, sales, and engineering service bases in 29 countries, as well as a network of distributors in some 80 countries. Mitutoyo maintains its rock-solid status as a leading global manufacturer providing services tailored to each regional society.



















Whatever your challenges are, Mitutoyo supports you from start to finish.

Mitutoyo is not only a manufacturer of top quality measuring products but one that also offers qualified support for the lifetime of the equipment, backed up by comprehensive services that ensure your staff can make the very best use of the investment.

Apart from the basics of calibration and repair, Mitutoyo offers product and metrology training, as well as IT support for the sophisticated software used in modern measuring technology. We can also design, build, test and deliver measuring solutions and even, if deemed cost-effective, take your critical measurement challenges in-house on a sub-contract basis.



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